

**Search Notes**

Application/Control No.

10/712,913

Examiner

Dah-Wei D. Yuan

Applicant(s)/Patent under  
Reexamination

DONAHUE ET AL.

Art Unit

1745

**SEARCHED**

Class	Subclass	Date	Examiner
429	12	12/22/2005	DWY
429	13	12/22/2005	DWY
429	19	12/22/2005	DWY

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	12/22/2005	DWY